

## SEMINARIUM RENTGENOWSKIE

Dnia 16.02.2016r. o godz. 10.30, w sali D Instytutu Fizyki PAN, odbędzie się seminarium rtg., na którym **dr Guillaume Brunetti** z JEOL (EUROPE), France, wygłosi referat na temat:

### ***"Latest developments and applications of JEOL non-corrected High Resolution Transmission Electron Microscope"***

#### **Streszczenie:**

Recent developments in design of modern, close-to-be-universal, multitasking and non-aberration corrected analytical High Resolution Electron Microscope (HRTEM) will be presented on example of the newest JEOL's 200 kV HRTEM model - the JEM-F200. Need for such innovative, yet reliable and researcher friendly(!) design is driven nowadays by the most demanding applications in almost every field of nanoscience, where high resolution imaging must go on par and at the same time with high resolution analytical techniques - to break scale and interpretation barriers. Result of JEOL's engineer team work will be illustrated by real world application examples.

Prof. dr hab. Krystyna Jabłońska  
Prof. nadzw. Piotr Dłużewski